Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/922,178	LEWIS, CRAIG	
Examiner	Art Unit	_
Mich Dieu Nauven	2127	

	SEARCHED		
Class	Subclass	Date	Examiner
713	184	2/9/2006	MDN
726	2, 6,18	2/9/2006	MDN

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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	<u>.</u>				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	2/9/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	2/9/2006	MDN
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